54ABT573 Octal D-Type Latch with TRI-STATE Outputs

## National Semiconductor

## 54ABT573 **Octal D-Type Latch with TRI-STATE® Outputs**

#### **General Description**

The 'ABT573 is an octal latch with buffered common Latch Enable (LE) and buffered common Output Enable (OE) inputs.

This device is functionally identical to the 'ABT373 but has different pinouts.

#### Features

- Inputs and outputs on opposite sides of package allow easy interface with microprocessors
- Useful as input or output port for microprocessors

- Functionally identical to 'ABT373
- TRI-STATE outputs for bus interfacing
- Output sink capability of 48 mA, source capability of 24 mA
- Output switching specified for both 50 pF and 250 pF loads
- Guaranteed latchup protection
- High impedance glitch-free bus loading during entire power up and power down
- Nondestructive hot insertion capability
- Standard Microcircuit Drawing (SMD) 5962-9321901

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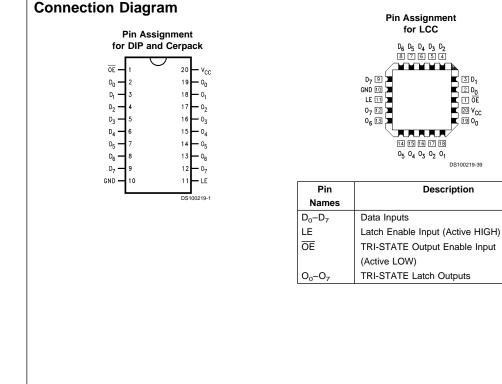
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DS100219-39

Description

#### **Ordering Code**

Military	Package Number	Package Description
54ABT573J-QML	J20A	20-Lead Ceramic Dual-In-Line
54ABT573W-QML	W20A	20-Lead Cerpack
54ABT573E-QML	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C



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#### **Functional Description**

The 'ABT573 contains eight D-type latches with TRI-STATE output buffers. When the Latch Enable (LE) input is HIGH, data on the  $D_n$  inputs enters the latches. In this condition the latches are transparent, i.e., a latch output will change state each time its D input changes. When LE is LOW the latches store the information that was present on the D inputs a setup time preceding the HIGH-to-LOW transition of LE. The TRI-STATE buffers are controlled by the Output Enable ( $\overline{OE}$ ) input. When  $\overline{OE}$  is LOW, the buffers are in the bi-state mode. When  $\overline{OE}$  is HIGH the buffers are in the high impedance mode but this does not interfere with entering new data into the latches.

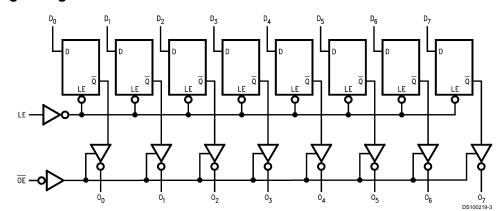
#### Logic Diagram

Function Table							
Inputs Outputs							
OE	LE	D	0				
L	Н	Н	Н				
L	н	L	L				
L	L	Х	Oo				
н	х	Х	Z				

H = HIGH Voltage Level

L = LOW Voltage Level

X = Immaterial $O_0 = Value$  stored from previous clock cycle



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

## Absolute Maximum Ratings (Note 1)

Storage Temperature	–65°C to +150°C
Ambient Temperature under Bias	–55°C to +125°C
Junction Temperature under Bias	
Ceramic	–55°C to +175°C
V <sub>CC</sub> Pin Potential to	
Ground Pin	-0.5V to +7.0V
Input Voltage (Note 2)	-0.5V to +7.0V
Input Current (Note 2)	-30 mA to +5.0 mA
Voltage Applied to Any Output	
in the Disabled or	
Power-Off State	-0.5V to +5.5V
in the HIGH State	–0.5V to V <sub>CC</sub>
Current Applied to Output	
in LOW State (Max)	Twice the rated $I_{OL}$ (mA)
DC Latchup Source Current	–500 mA

Over Voltage Latchup (I/O)

# Recommended Operating Conditions

Free Air Ambient Temperature	
Military	–55°C to +125°C
Supply Voltage	
Military	+4.5V to +5.5V
Minimum Input Edge Rate	$(\Delta V / \Delta t)$
Data Input	50 mV/ns
Enable Input	20 mV/ns
<b>Note 1:</b> Absolute maximum ratings are values be damaged or have its useful life impaired. Fu conditions is not implied.	

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

## **DC Electrical Characteristics**

Symbol	Para	Parameter		ABT573		Units	V <sub>cc</sub>	Conditions
			Min	Тур	Max	1		
VIH	Input HIGH Voltage		2.0			V		Recognized HIGH Signal
VIL	Input LOW Voltage				0.8	V		Recognized LOW Signal
V <sub>CD</sub>	Input Clamp Diode Volta	age			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	54ABT	2.5			V	Min	I <sub>OH</sub> = -3 mA
		54ABT	2.0					I <sub>OH</sub> = -24 mA
V <sub>OL</sub>	Output LOW Voltage	54ABT			0.55	V	Min	I <sub>OL</sub> = 48 mA
IIH	Input HIGH Current				5	μA	Max	V <sub>IN</sub> = 2.7V (Note 4)
					5			V <sub>IN</sub> = V <sub>CC</sub>
I <sub>BVI</sub>	Input HIGH Current				7	μA	Max	V <sub>IN</sub> = 7.0V
	Breakdown Test							
I <sub>IL</sub>	Input LOW Current				-5	μA	Max	V <sub>IN</sub> = 0.5V (Note 4)
					-5			V <sub>IN</sub> = 0.0V
V <sub>ID</sub>	Input Leakage Test		4.75			V	0.0	I <sub>ID</sub> = 1.9 μA
								All Other Pins Grounded
I <sub>OZH</sub>	Output Leakage Current	t			50	μA	0 – 5.5V	$V_{OUT} = 2.7V; \overline{OE} = 2.0V$
I <sub>OZL</sub>	Output Leakage Current	t			-50	μA	0 – 5.5V	$V_{OUT} = 0.5V; \overline{OE} = 2.0V$
I <sub>OS</sub>	Output Short-Circuit Cur	rrent	-100		-275	mA	Max	$V_{OUT} = 0.0V$
I <sub>CEX</sub>	Output High Leakage C	urrent			50	μA	Max	$V_{OUT} = V_{CC}$
I <sub>ZZ</sub>	Bus Drainage Test				100	μA	0.0	V <sub>OUT</sub> = 5.5V; All Others GND
I <sub>CCH</sub>	Power Supply Current				50	μA	Max	All Outputs HIGH
I <sub>CCL</sub>	Power Supply Current				30	mA	Max	All Outputs LOW
I <sub>CCZ</sub>	Power Supply Current				50	μA	Max	$\overline{OE} = V_{CC}$
								All Others at V <sub>CC</sub> or GND
I <sub>CCT</sub>	Additional I <sub>CC</sub> /Input	Outputs Enabled			2.5	mA		$V_{I} = V_{CC} - 2.1V$
		Outputs TRI-STATE			2.5	mA	Max	Enable Input $V_I = V_{CC} - 2.1V$
		Outputs TRI-STATE			2.5	mA		Data Input V <sub>I</sub> = V <sub>CC</sub> - 2.1V
								All Others at $V_{CC}$ or GND
I <sub>CCD</sub>	Dynamic I <sub>CC</sub>	No Load				mA/	Max	Outputs Open
	(Note 4)				0.12	MHz		$\overline{OE}$ = GND, LE = V <sub>CC</sub> (Note 3)
								One Bit Toggling, 50% Duty Cycle

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Note 3: For 8 bits toggling,  $I_{\rm CCD}$  < 0.8 mA/MHz.

Note 4: Guaranteed but not tested.

10V

DC	Flectrical	Characteristics
		Characteristics

Symbol         Parameter         Min         Max         Units         V <sub>cc</sub> Conditions						
Gymbol	i arameter	WIIII	Max	Onits	▼cc	$C_L = 50 \text{ pF}, R_L = 500\Omega$
V <sub>OLP</sub>	Quiet Output Maximum Dynamic V <sub>OL</sub>		0.9	V	5.0	$T_A = 25^{\circ}C$ (Note 5)
V <sub>OLV</sub>	Quiet Output Minimum Dynamic V <sub>OL</sub>		-1.7	V	5.0	$T_A = 25^{\circ}C$ (Note 5)

Note 5: Max number of outputs defined as (n). n – 1 data inputs are driven 0V to 3V. One output at LOW. Guaranteed, but not tested.

### **AC Electrical Characteristics**

Symbol	Parameter	54ABT		eter 54ABT		Units	Fig.
	$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = 4.5V \text{ to } 5.5V$			No.			
			$V_{cc}$ = 4.5V to 5.5V		$V_{CC} = 4.5V$ to 5.5V		
		C <sub>L</sub> =	50 pF				
	Γ	Min	Max				
t <sub>PLH</sub>	Propagation Delay	1.0	6.4	ns	Figure 4		
t <sub>PHL</sub>	D <sub>n</sub> to O <sub>n</sub>	1.5	6.7				
t <sub>PLH</sub>	Propagation Delay	1.0	7.1	ns	Figure 4		
t <sub>PHL</sub>	LE to O <sub>n</sub>	1.5	7.5				
t <sub>PZH</sub>	Output Enable Time	0.8	6.5	ns	Figure 6		
t <sub>PZL</sub>		1.5	7.2				
t <sub>PHZ</sub>	Output Disable Time	1.5	7.7	ns	Figure 6		
t <sub>PLZ</sub>	Time	1.0	7.0				

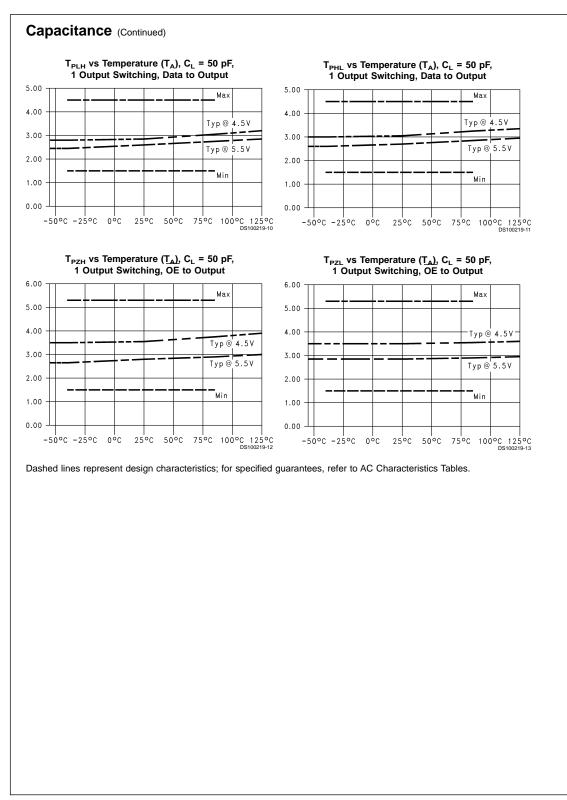
## **AC Operating Requirements**

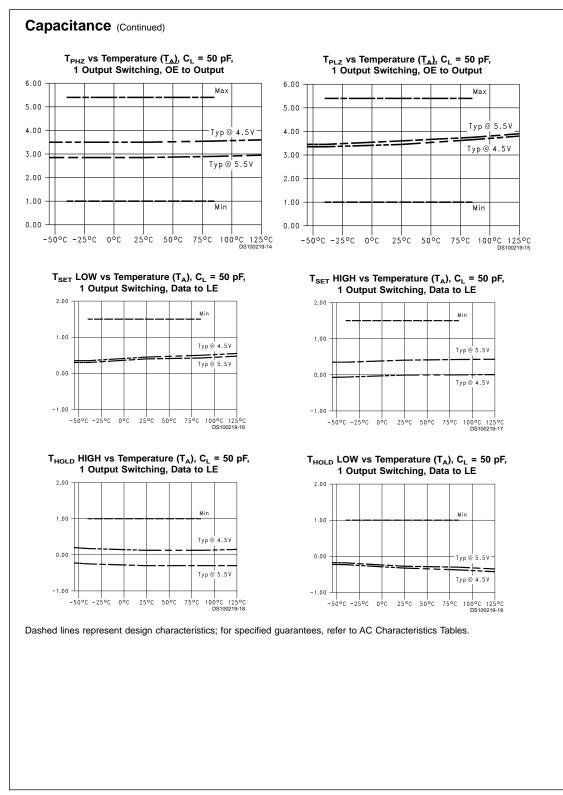
Symbol	Parameter	$\frac{54ABT}{T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C}$ $V_{CC} = 4.5V \text{ to } 5.5V$ $C_{L} = 50 \text{ pF}$		$T_A = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = 4.5V \text{ to } 5.5V$		Units	Fig. No.
		Min	Max				
t <sub>s</sub> (H)	Set Time, HIGH	2.5		ns	Figure 7		
t <sub>s</sub> (L)	or LOW D <sub>n</sub> to LE	2.5					
t <sub>h</sub> (H)	Hold Time, HIGH	2.5		ns	Figure 7		
t <sub>h</sub> (L)	or LOW D <sub>n</sub> to LE	2.5					
t <sub>w</sub> (H)	Pulse Width,	3.3		ns	Figure 5		
	LE HIGH						

## Capacitance

Symbol	Parameter	Тур	Units	Conditions		
				(T <sub>A</sub> = 25°C)		
C <sub>IN</sub>	Input Capacitance	5	pF	$V_{CC} = 0V$		
C <sub>OUT</sub> (Note 6)	Output Capacitance	9	pF	$V_{CC} = 5.0V$		

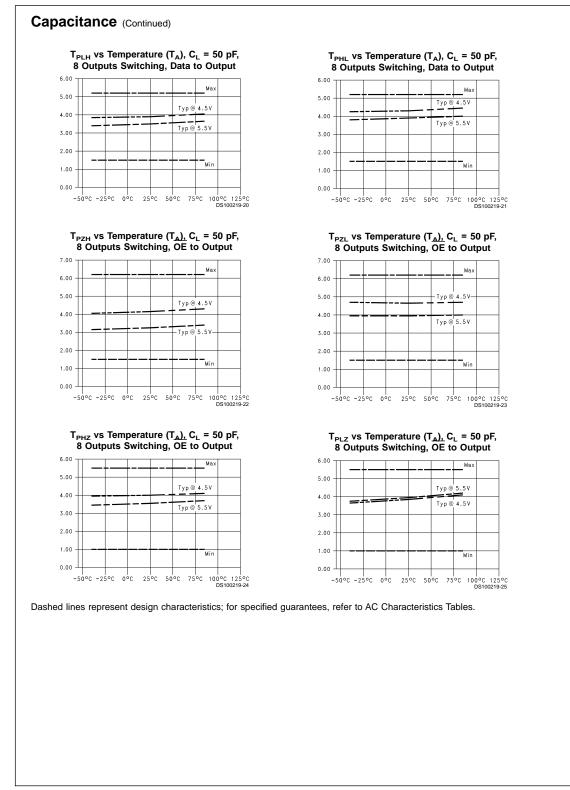
Note 6:  $C_{OUT}$  is measured at frequency f = 1 MHz per MIL-STD-883B, Method 3012.



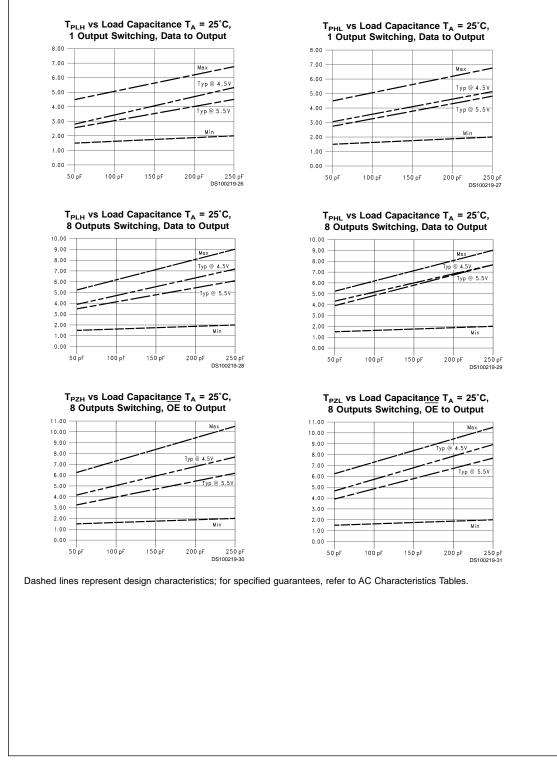


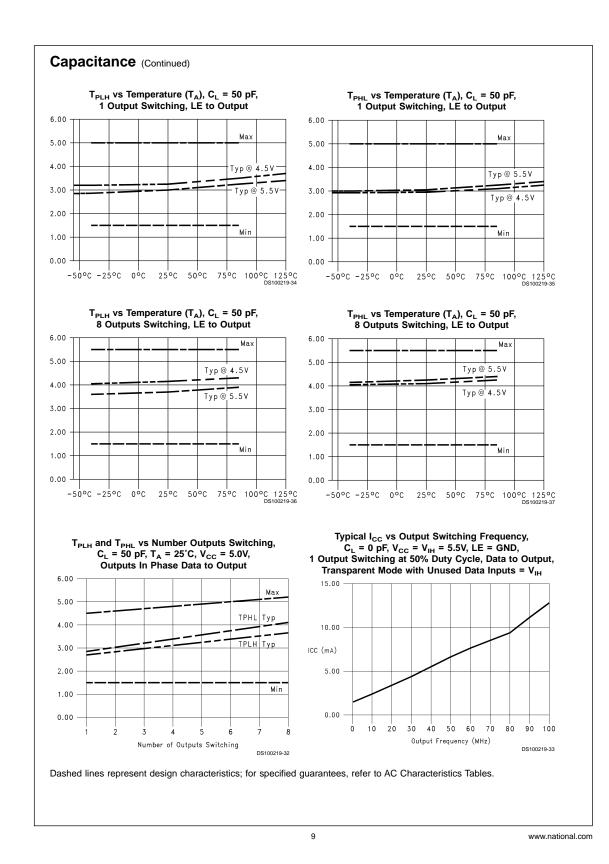
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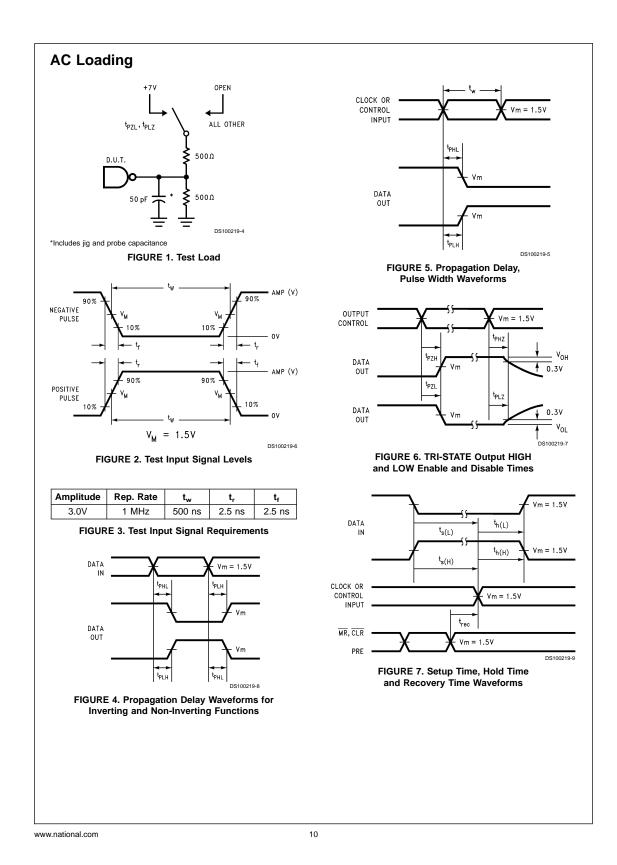
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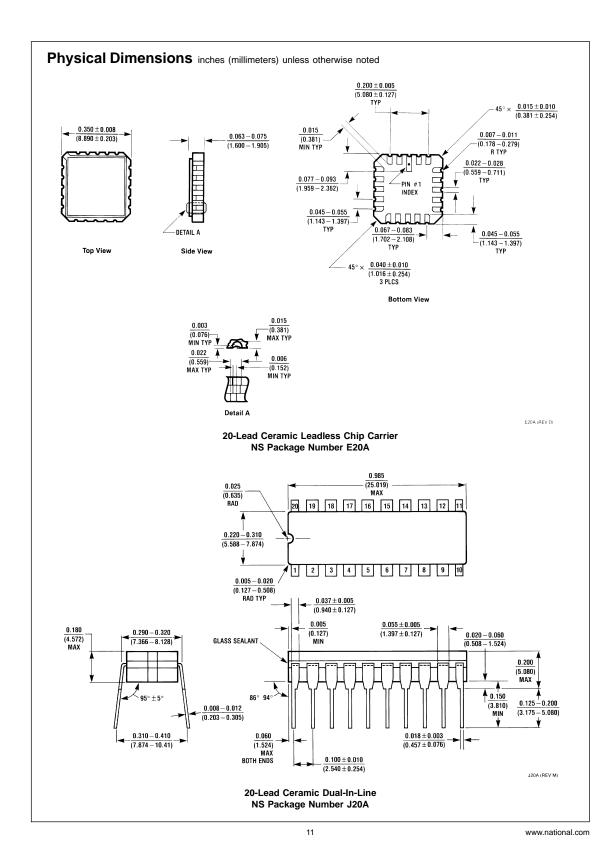


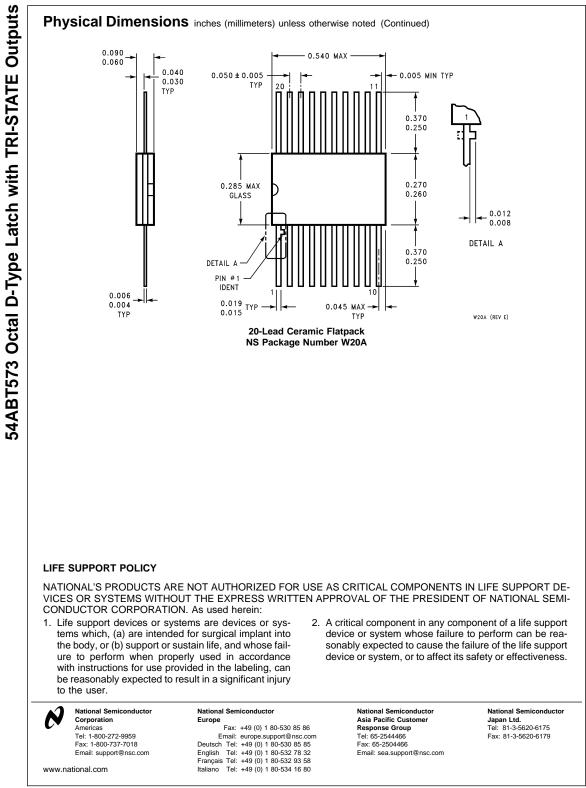






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